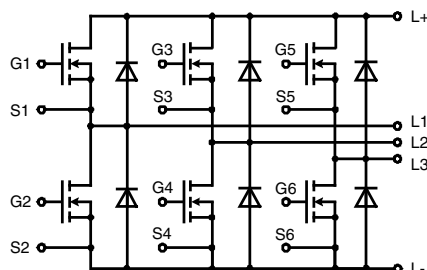


Three phase full Bridge with Trench MOSFETs in DCB isolated high current package

$$V_{DSS} = 75 \text{ V}$$

$$I_{D25} = 110 \text{ A}$$

$$R_{DSon \text{ typ.}} = 4.0 \text{ m}\Omega$$



Straight leads



Surface Mount Device

MOSFETs

Symbol	Conditions	Maximum Ratings
V_{DSS}	$T_{VJ} = 25^{\circ}\text{C to } 150^{\circ}\text{C}$	75 V
V_{GS}		± 20 V
I_{D25}	$T_C = 25^{\circ}\text{C}$	110 A
I_{D90}	$T_C = 90^{\circ}\text{C}$	85 A
I_{F25}	$T_C = 25^{\circ}\text{C}$ (diode)	110 A
I_{F90}	$T_C = 90^{\circ}\text{C}$ (diode)	80 A

Applications

- AC drives
 - in automobiles
 - electric power steering
 - starter generator
 - in industrial vehicles
 - propulsion drives
 - fork lift drives
- in battery supplied equipment

Features

- MOSFETs in trench technology:
 - low R_{DSon}
 - optimized intrinsic reverse diode
- package:
 - high level of integration
 - high current capability 300 A max.
 - aux. terminals for MOSFET control
 - terminals for soldering or welding connections
 - isolated DCB ceramic base plate with optimized heat transfer
- Space and weight savings

Package options

- 2 lead forms available
 - straight leads (SL)
 - SMD lead version (SMD)

Symbol	Conditions	Characteristic Values				
(T _{VJ} = 25°C, unless otherwise specified)						
		min.	typ.	max.		
R _{DSon}	on chip level at V _{GS} = 10 V; I _D = 60 A	T _{VJ} = 25°C T _{VJ} = 125°C	4.0 7.2	4.9 8.4	mΩ	
V _{GS(th)}	V _{DS} = 20 V; I _D = 1 mA		2	4	V	
I _{DSS}	V _{DS} = V _{DSS} ; V _{GS} = 0 V	T _{VJ} = 25°C T _{VJ} = 125°C		0.1 1	μA mA	
I _{GSS}	V _{GS} = ± 20 V; V _{DS} = 0 V			0.2	μA	
Q _g Q _{gs} Q _{gd}	V _{GS} = 10 V; V _{DS} = 36 V; I _D = 25 A		115 30 30		nC nC nC	
t _{d(on)} t _r t _{d(off)} t _f			130 100 500 100		ns ns ns ns	
E _{on} E _{off} E _{recoff}			0.20 0.50 0.01		mJ mJ mJ	
R _{thJC} R _{thJH}		with heat transfer paste (IXYS test setup)		1.3	1.0 1.6	K/W K/W

Recommended replacement: MTI 90W75GA / MTI 90W75GC

Source-Drain Diode

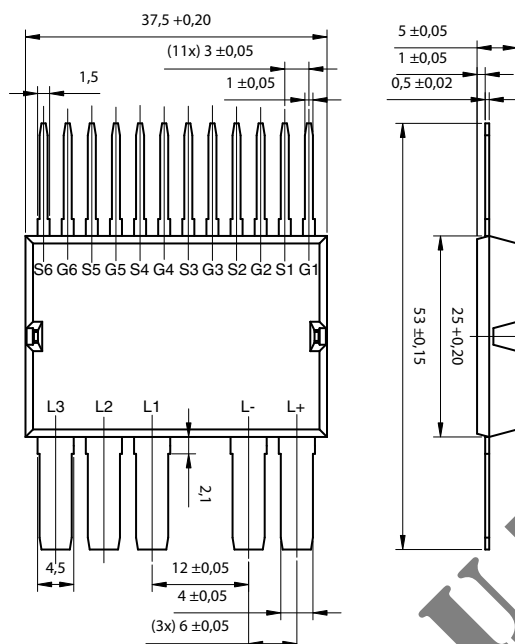
Symbol	Conditions	Characteristic Values			
		(T _J = 25°C, unless otherwise specified)			
		min.	typ.	max.	
V _{SD}	(diode) I _F = 80 A; V _{GS} = 0 V		0.9	1.2	V
t _{rr}	I _F = 80 A; -di _F /dt = 800 A/μs		55		ns
Q _{RM}	V _R = 30 V; T _J = 125°C		0.9		μC
I _{RM}			30		A

Component

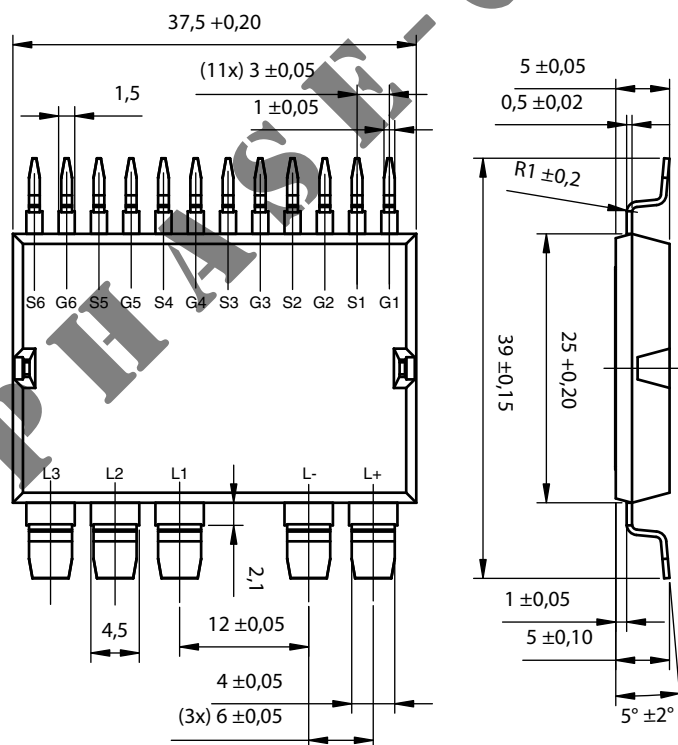
Symbol	Conditions	Maximum Ratings	
I _{RMS}	per pin in main current paths (P+, N-, L1, L2, L3) may be additionally limited by external connections	300	A
T _{VJ}		-55...+175	°C
T _{stg}		-55...+125	°C
V _{ISOL}	I _{ISOL} ≤ 1 mA, 50/60 Hz, f = 1 minute	1000	V~
F _C	mounting force with clip	50 - 250	N

Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
R _{pin to chip}	with heatsink compound		0.6	mΩ
C _P	coupling capacity between shorted pins and mounting tab in the case		160	pF
Weight	typ.		25	g

Straight Leads GWM 120-0075X1-SL



Surface Mount Device GWM 120-0075X1-SMD



Leads	Ordering	Part Name & Packing Unit Marking	Part Marking	Delivering Mode	Base Qty.	Ordering Code
Straight	Standard	GWM 120-0075X1 - SL	GWM 120-0075X1	Blister	28	505 960
SMD	Standard	GWM 120-0075X1 - SMD	GWM 120-0075X1	Blister	28	505 581

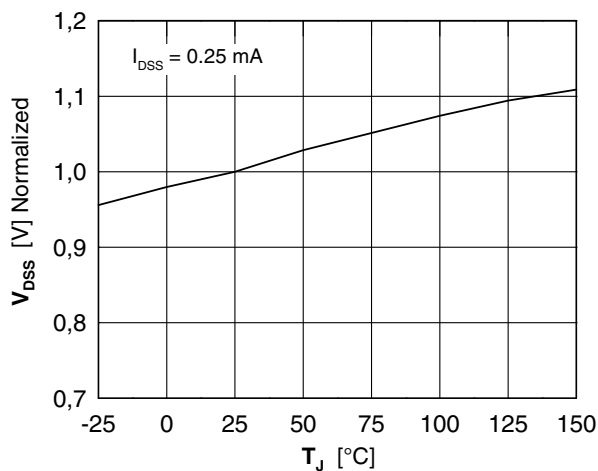


Fig. 1 Drain source breakdown voltage V_{DS} vs. junction temperature T_J

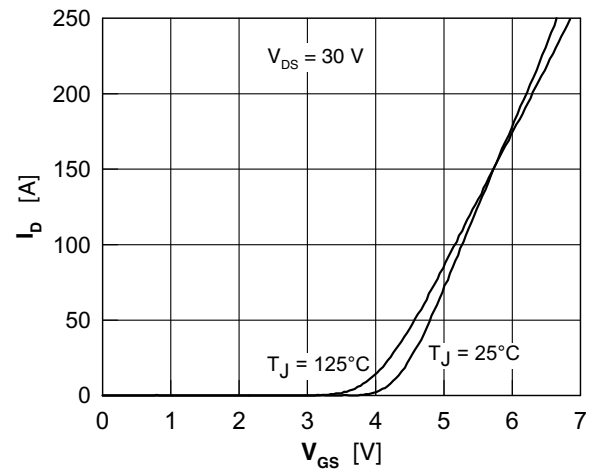


Fig. 2 Typical transfer characteristic

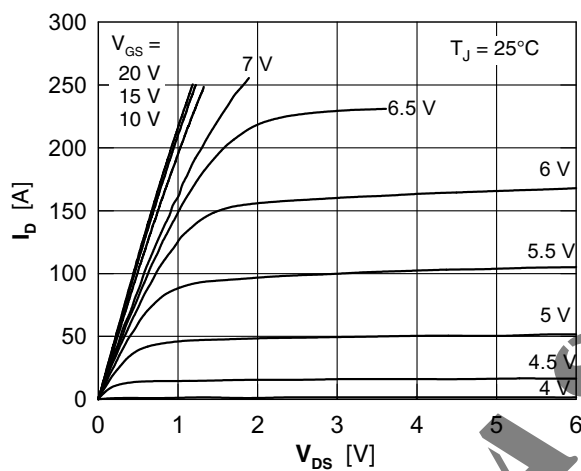


Fig. 3 Typical output characteristic

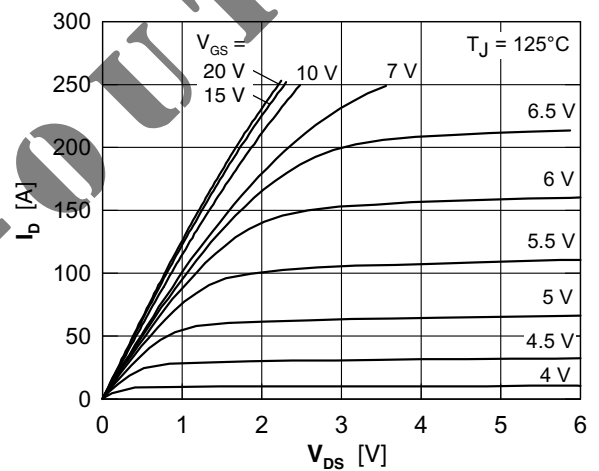


Fig. 4 Typical output characteristic

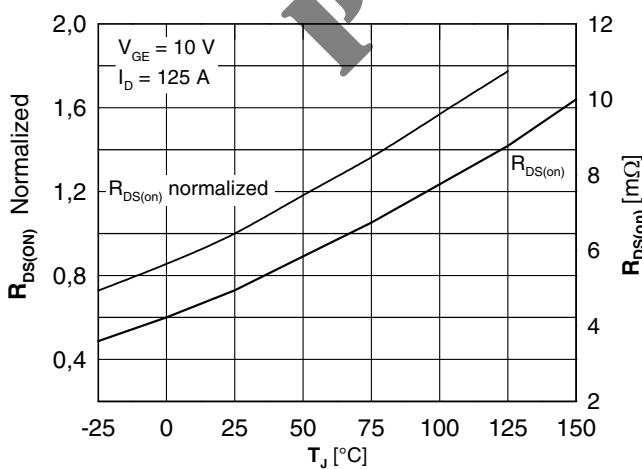


Fig. 5 Drain source on-state resistance $R_{DS(on)}$ versus junction temperature T_J

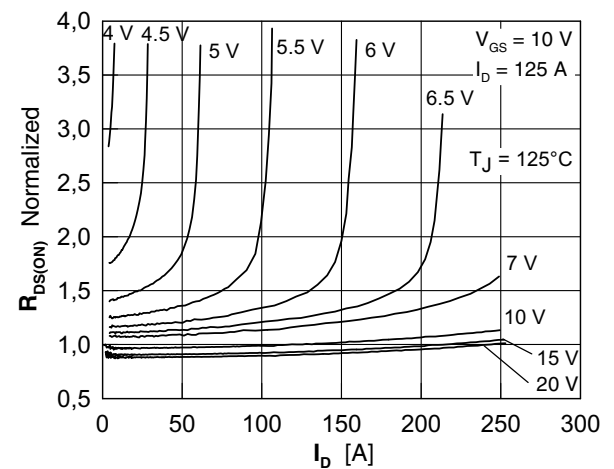


Fig. 6 Drain source on-state resistance $R_{DS(on)}$ versus I_D

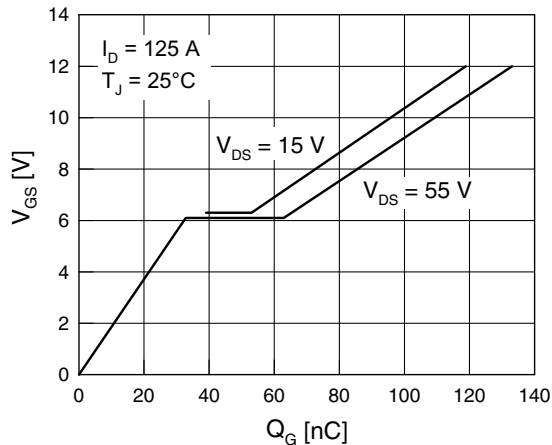


Fig. 7 Gate charge characteristic

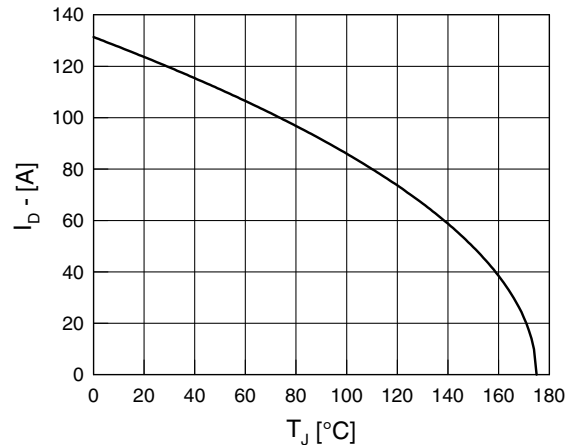


Fig. 8 Drain current I_D vs. case temperature T_J

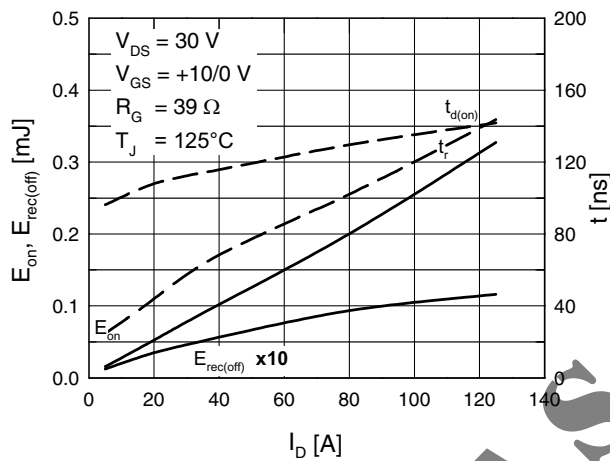


Fig. 9 Typ. turn-on energy & switching times vs. collector current, inductive switching

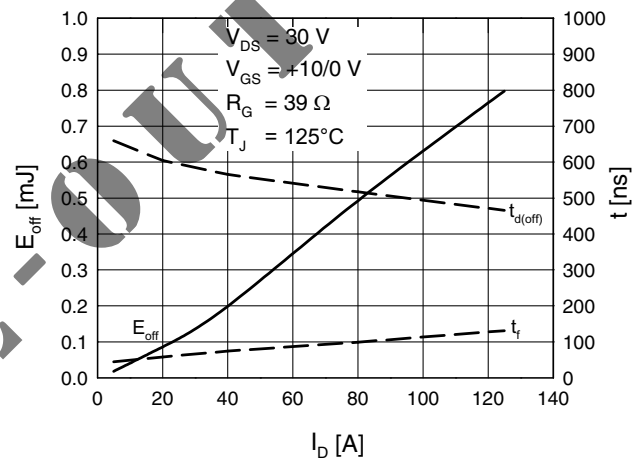


Fig. 10 Typ. turn-off energy & switching times vs. collector current, inductive switching

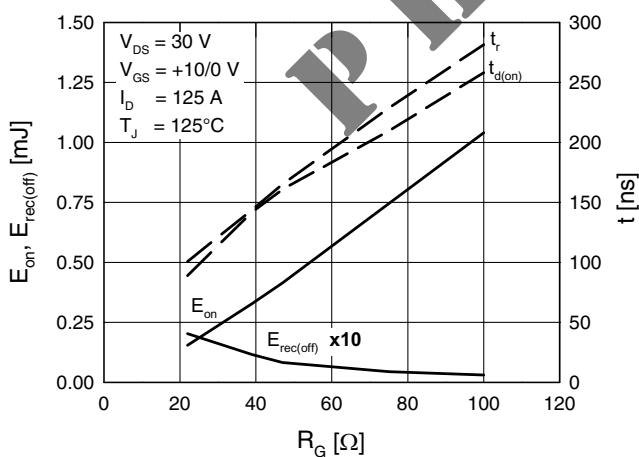


Fig. 11 Typ. turn-on energy & switching times vs. gate resistor, inductive switching

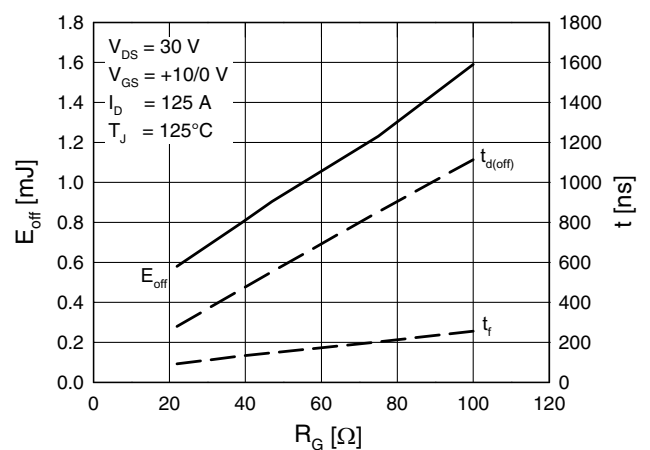


Fig. 12 Typ. turn-off energy & switching times vs. gate resistor, inductive switching

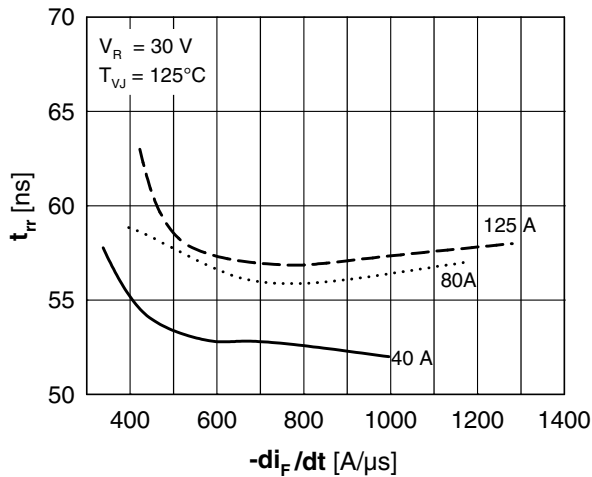


Fig. 13 Reverse recovery time t_{rr} of the body diode vs. di/dt

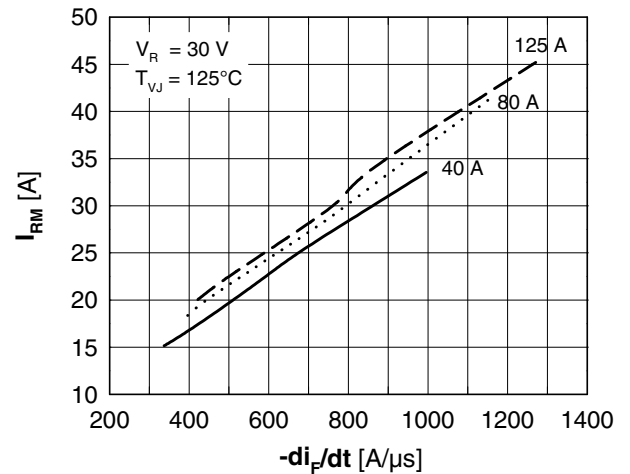


Fig. 14 Reverse recovery current I_{RM} of the body diode vs. di/dt

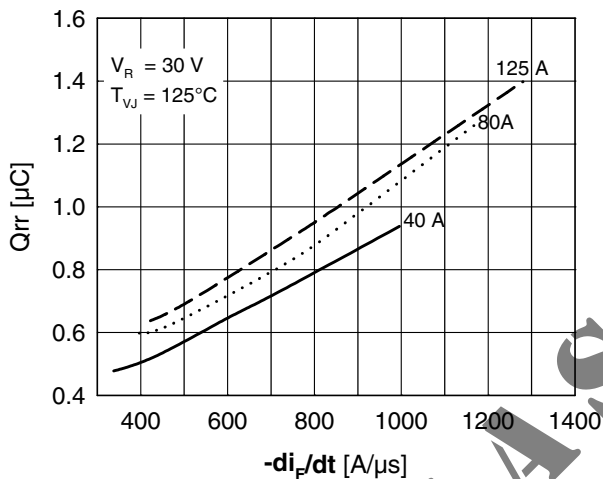


Fig. 15 Reverse recovery charge Q_{rr} of the body diode vs. di/dt

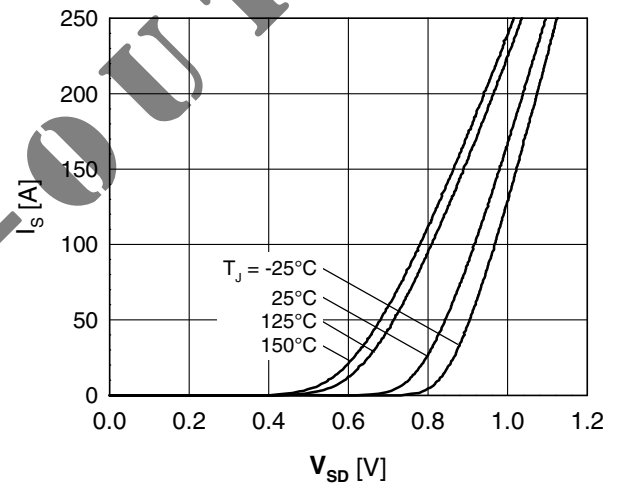


Fig. 16 Source current I_S vs. source drain voltage V_{SD} (body diode)

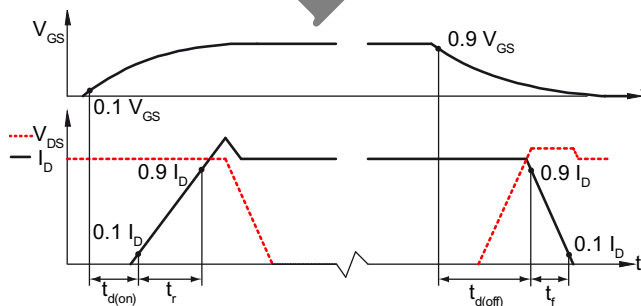


Fig. 17 Definition of switching times

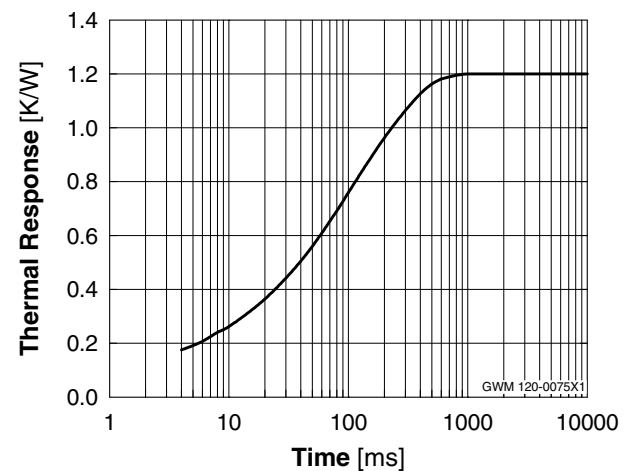


Fig. 18 Typ. therm. impedance junction to heatsink Z_{thJC}